

Up to 24V Supply, 4-A Dual Channel High Speed Low Side Driver

FEATURES

- Wide Supply Voltage Range: 4.5V 24V
- 4A Peak Source Current and 4A Peak Sink
 Current

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- Negative Input Voltage Capability: Down to -5V
- TTL Compatible Input Logic Threshold
- Propagation Delay: 13ns
- Typical Rising and Falling Times: 8ns
- Low Quiescent Current: 55uA
- Output Low When Input Floating
- Independent Enable Logic for Each Channel
- Thermal Shutdown Protection: 170°C
- Available in SOP-8 Package

APPLICATIONS

- IGBT/MOSFET Gate Driver
- Variable Frequency-Drive (VFD)
- Switching Power Supply
- Motor Control
- Solar Power Inverter

DESCRIPTION

The SCT52241 is a wide supply, dual channel, high speed, low side gate drivers for both power MOSFET and IGBT. Each channel can source and sink 4A peak current along with rail-to-rail output capability. The 24V power supply rail enhances the driver output ringing endurance during the power device transition.

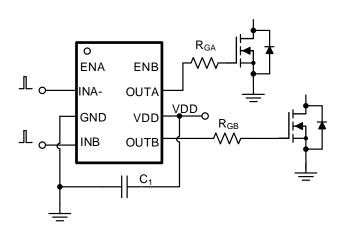
The minimum 13ns input to output propagation delay enables the SCT52241 suitable for high frequency power converter application.

The SCT52241 features wide input hysteresis that is compatible for TTL low voltage logic. The SCT52241 has the capability to handle negative input down to -5V, which increases the input noise immunity.

The SCT52241 has very low quiescent current that reduces the stand-by loss in the power converter. The SCT52241 each channel driver adopts non-overlap driver design to avoid the shoot-through of output stage.

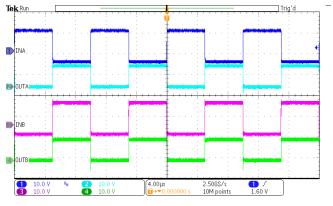
The SCT52241 features 170°C thermal shut down. The SCT52241 is available in SOP-8 package

TYPICAL APPLICATION



SCT52241 Typical Application

Application Waveform





REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Revision 1.0: Production.

Revision 1.1: Format adjustment, update ABS max, add EC table max limit

DEVICE ORDER INFORMATION

PART NUMBER	PACKAGE MARKING	PACKAGE DISCRIPTION
SCT52241STD	2241	SOP-8

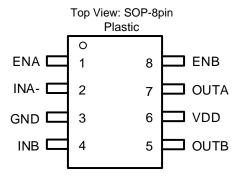
1) For Tape & Reel, Add Suffix R (e.g. SCT52241STDR).

ABSOLUTE MAXIMUM RATINGS

Over operating free-air temperature unless otherwise noted⁽¹⁾

DESCRIPTION	MIN	MAX	UNIT
ENA, ENB	-0.3	26	V
INA-, INB	-5	26	V
OUTA, OUTB	-0.3	VDD+0.3	V
VDD	-0.3	26	V
Operating junction temperature TJ ⁽²⁾	-40	150	°C
Storage temperature T_{STG}	-65	150	°C

PIN CONFIGURATION

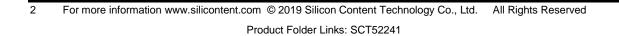


(1) Stresses beyond those listed under Absolut Maximum Rating may cause device permanent damage. The device is not guaranteed to function outside of its Recommended Operation Conditions.

(2) The IC includes over temperature protection to protect the device during overload conditions. Junction temperature will exceed 150°C when over temperature protection is active. Continuous operation above the specified maximum operating junction temperature will reduce lifetime

PIN FUNCTIONS

NAME	NO.	PIN FUNCTION
ENA	1	Channel A enable logic input, TTL compatible. Floating logic high.
INA-	2	Channel A logic input, TTL compatible. Floating logic low.
GND	3	Power ground. Must be soldered directly to ground plane for thermal performance improvement and electrical contact.
INB	4	Channel B logic input, TTL compatible. Floating logic low.
OUTB	5	Channel B gate driver output
VDD	6	Power Supply, must be locally bypassed by the ceramic cap.
OUTA	7	Channel A gate driver output
ENB	8	Channel B enable logic input, TTL compatible. Floating logic high.





RECOMMENDED OPERATING CONDITIONS

Over operating free-air temperature range unless otherwise noted

PARAMETER	DEFINITION	MIN	MAX	UNIT
Vdd	Supply voltage range	4.5	24	V
VINA-,INB	Input voltage range	-5	24	
TJ	Operating junction temperature	-40	150	°C

ESD RATINGS

PARAMETER	DEFINITION	MIN	МАХ	UNIT
Vesd	Human Body Model (HBM), per ANSI-JEDEC-JS-001- 2014 specification, all pins ⁽¹⁾	-2	+2	kV
	Charged Device Model (CDM), per ANSI-JEDEC-JS-002- 2014specification, all pins ⁽¹⁾	-0.5	+0.5	kV

(1) HBM and CDM stressing are done in accordance with the ANSI/ESDA/JEDEC JS-001-2014 specification

THERMAL INFORMATION

PARAMETER	THERMAL METRIC	SOP-8L	UNIT
R _{0JA}	Junction to ambient thermal resistance ⁽¹⁾ 130		°C/W
Rejc	Junction to case thermal resistance ⁽¹⁾	80	0/00

(1) SCT provides $R_{\theta,JA}$ and $R_{\theta,JC}$ numbers only as reference to estimate junction temperatures of the devices. $R_{\theta,JA}$ and $R_{\theta,JC}$ are not a characteristic of package itself, but of many other system level characteristics such as the design and layout of the printed circuit board (PCB) on which the SCT52241 is mounted, and external environmental factors. The PCB board is a heat sink that is soldered to the leads and thermal pad of the SCT52241. Changing the design or configuration of the PCB board changes the efficiency of the heat sink and therefore the actual $R_{\theta,JA}$ and $R_{\theta,JC}$.



ELECTRICAL CHARACTERISTICS

 V_{DD} =12V, T_J=-40°C~150°C, typical values are tested under 25°C.

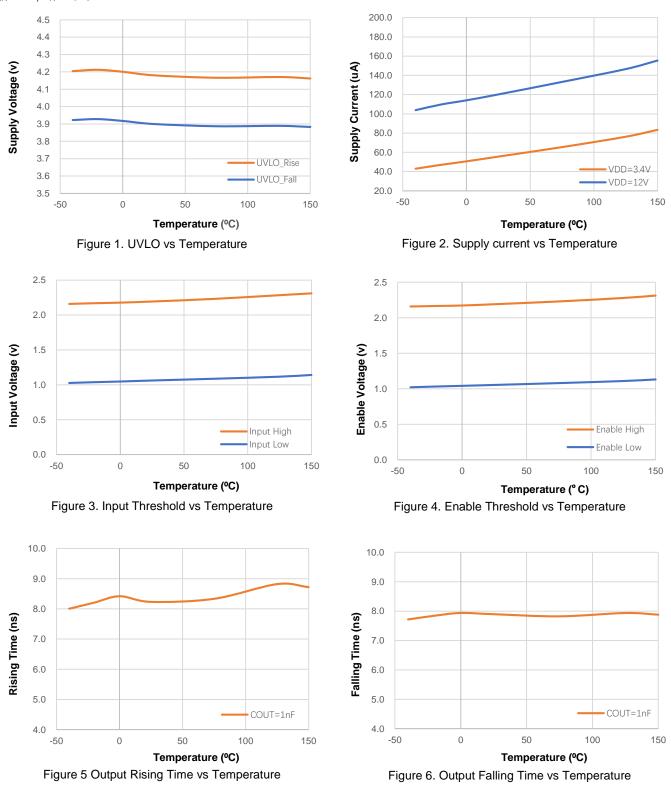
SYMBOL	PARAMETER	TEST CONDITION	MIN	ΤΥΡ	MAX	UNIT
Power Sup	ply and Output					1
V _{DD}	Operating supply voltage		4.5		24	V
Vdd_uvlo	Input UVLO	V _{DD} rising		4.2	4.5	V
VDD_UVLO	Hysteresis			300		mV
	Querra la compact	EN=V _{DD} =3.5V , INA- =INB= 3.5V		55		uA
Ι _Q	Supply current	EN=V _{DD} =12V, INA- =INB= V _{DD} =12V		120		uA
INPUTS						
Vina-,inb_h	Input logic high threshold Output low for inverting input Output high for non-inverting input			2.1	2.4	V
Vina-,inb_l	Input logic low threshold Output high for inverting input Output low for non-inverting input		0.8	1		V
VIN_Hys	Hysteresis			1.1		V
Vena,enb_h	Enable logic high threshold			2.1	2.4	V
Vena,enb_l	Enable logic low threshold		0.8	1		V
V _{EN_Hys}	Hysteresis			1.1		V
OUTPUTS						
Vdd_Voh	Output – output high voltage	I _{OUT} = - 10mA			150	mV
Vol	Output low voltage	I _{OUT} = 10mA			10	mV
ISINK/SRC	Output sink/source peak current	C _{Load} =10nF, F _{SW} =1kHz		4		А
Rон	Output pull high resistance (only PMOS ON)	Ι _{ΟUT} = - 10mA	5	9	18	Ω
Rol	Output pull low resistance	Iout= 10mA	0.3	0.6	1.2	Ω
Timing						
T _R	Output rising time	C _{Load} =1nF		8	20	ns
T _F	Output falling time	C _{Load} =1nF		8	20	ns
Td_in	Input to output propagation delay, Rising edge		7	13	25	ns
I D_IN	Input to output propagation delay, Falling edge		7	13	25	ns
T _{M_IN}	Input to output delay matching			1	4	ns
T _{MIN_ON}	Minimum input pulse width	C _{Load} =1nF		20	30	ns
Protection						
 т	Thermal shutdown threshold	T _J rising		170		°C
T _{SD}	Hysteresis			25		°C



SCT52241

TYPICAL CHARACTERISTICS

V_{IN}=12V, T_A= 25°C.



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SCT52241

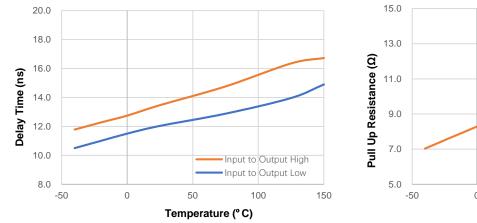
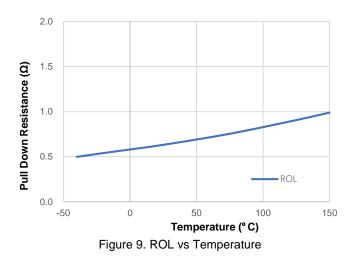


Figure 7. Input to Output Propagation Delay vs Temperature



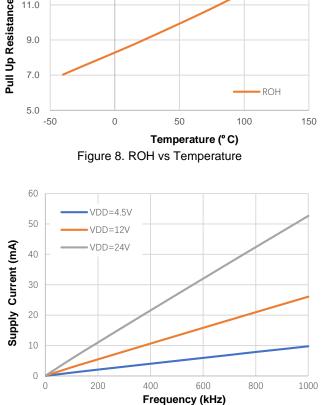
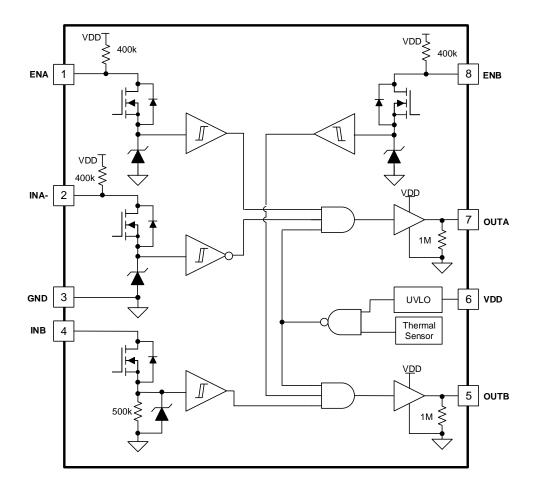


Figure 10. Operation Supply Current vs Frequency, Cout=1nF



FUNCTIONAL BLOCK DIAGRAM





OPERATION

Overview

The SCT52241 is a dual-channel high-speed low side driver with supporting up to 24V wide supply for both power MOSFET and IGBT. Each channel can source and sink 4A peak current along with the minimum propagation delay 13ns from input to output. The ability to handle -5V DC input increases the noise immunity of driver input stage, the 24V rail-to-rail output improves the SCT52241 output stage robustness during switching load fast transition. The SCT52241 has flexible input and enable pin configuration, table 1 shows the device output logic truth table.

ENA	ENB	INA-	INB	OUTA	OUTB
н	н	L	L	н	L
н	н	L	н	н	Н
н	н	н	L	L	L
н	н	н	н	L	Н
L	L	Any	Any	L	L
Any	Any	Floating	Floating	L	L
Floating	Floating	L	L	н	L
Floating	Floating	L	н	н	Н
Floating	Floating	н	L	L	L
Floating	Floating	Н	Н	L	Н

. Table 1: the SCT52241 Device Logic.

VDD Power Supply

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The SCT52241 operates under a supply voltage range between 4.5V to 24V. For the best high-speed circuit performance, two VDD bypass capacitors in parallel are recommended to prevent noise problems on supply VDD. A 0.1- μ F surface mount ceramic capacitor must be located as close as possible to the VDD to GND pins of the SCT52241. In addition, a larger capacitor (such as 1- μ F or 10 μ F) with relatively low ESR must be connected in parallel, in order to help avoid the unexpected VDD supply glitch. The parallel combination of capacitors presents a low impedance characteristic for the expected current levels and switching frequencies in the application.

Under Voltage Lockout (UVLO)

SCT52241 device Under Voltage Lock Out (UVLO) rising threshold is typically 4.2 V with 300-mV typical hysteresis. When VDD is rising and the level is still below UVLO threshold, this circuit holds the output low regardless of the status of the inputs. The hysteresis prevents output bouncing when low VDD supply voltages have noise from the power supply. The capability to operate at low voltage below 5 V, is especially suited for driving new emerging wide band gap power device like GaN. For example, at power up, the driver output remains low until the VDD voltage reaches the UVLO threshold if enable pin is active or floating. The magnitude of the OUT signal rises with VDD until steady state VDD reached.

The non-inverting operation in Figure 11 shows that the output remains low until the UVLO threshold reached, and then the output is in-phase with the input.



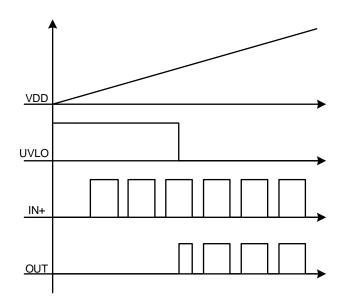


Figure 11. SCT52241 Non-inverting Output Vs VDD

Enable Function

SCT52241 provides independent enable pins ENA and ENB for external control of each channel operation. The enable pins are based on a TTL compatible input-threshold logic that is independent of the supply voltage and is effectively controlled with logic signals from 3.3-V and 5-V microcontrollers. When applying a voltage higher than the high threshold (typical 2.1V) the pin, the SCT52241 enables all functions and starts gate driver operation. Driver operation is disabled when ENx voltage falls below its lower threshold (typical 1V). The ENx pins are internally pulled up to VDD with 400k pullup resistors. Hence, the ENx pins are left floating or Not Connected (N/C) for standard operation, where the enable feature is not required.

Input Stage

The input of SCT52241 is compatible on TTL input-threshold logic that is independent of the VDD supply voltage. With typically high threshold = 2.1 V and typically low threshold = 1 V, the logic level thresholds are conveniently driven with PWM control signals derived from 3.3-V and 5-V digital power-controller devices. Wider hysteresis offers enhanced noise immunity compared to traditional TTL logic implementations, where the hysteresis is typically less than 0.5V. SCT52241 also features tight control of the input pin threshold voltage that ensures stable operation across temperature. The very low input parasitic capacitance on the input pins increases switching speed and reduces the propagation delay.

Output Stage

The SCT52241 output stage features the pull up structure with P-type MOSFET PM1 and N-type MOSFET NM1 in parallel, as shown in Figure 12. PM1 provides the pull up capability when OUT approaches VDD and the NM1 holds off state, which guarantees the driver output is up to VDD rail. The measurable on-resistance R_{OH} in steady state is the conduction resistance of PM1. NM1 provides a narrow instant peak sourcing current up to 4A to eliminate the turn on time and delay. During the output turn on transition, the equivalent hybrid pull on transient resistance is 1.5R_{OL}, which is much lower than the DC measured R_{OH} .

The N-type MOSFET NM2 composes the output stage pull down structure; the R_{OL} is the DC measurement and represents the pull down impedance. The output stage of SCT52241 provides rail-to-rail operation, and is able to supply 4A sourcing and 4A sinking peak current. The presence of the MOSFET-body diodes also offers low impedance to switching overshoots and undershoots. The outputs of the dual channel drivers are designed to withstand 500-mA reverse current without either damaging the device or logic malfunction.



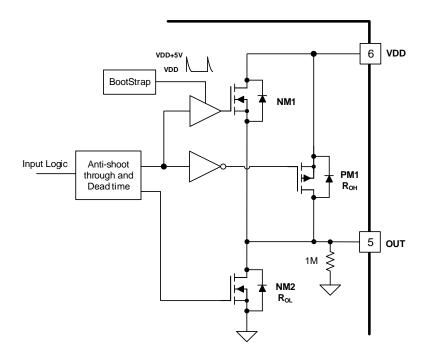


Figure 12. SCT52241 Output Stage

Thermal Shutdown

Once the junction temperature in the SCT52241 exceeds 170° C, the thermal sensing circuit stops switching until the junction temperature falling below 145° C, and the device restarts. Thermal shutdown prevents the damage on device during excessive heat and power dissipation condition.



APPLICATION INFORMATION

Typical Application

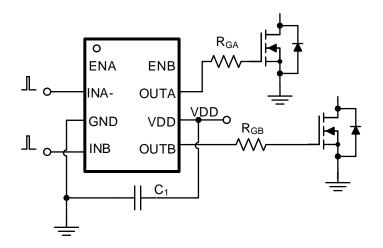


Figure 16. Dual Channel Driver Typical Application

Driver Power Dissipation

Generally, the power dissipated in the SCT52241 depends on the gate charge required of the power device (Qg), switching frequency, and use of external gate resistors. The SCT52241 features very low quiescent currents and internal logic to eliminate any shoot-through in the output driver stage, their effect on the power dissipation within the gate driver is negligible.

For the pure capacitive load, the power loss of each channel in SCT52241 is:

$$P_G = C_{Load} * V_{DD}^2 * f_{SW}$$

(1)

Where

- V_{DD} is supply voltage
- C_{Load} is the output capacitance
- F_{sw} is the switching frequency

For the the switching load of power MOSFET, the power loss of each channel in the SCT52241 is shown in equation (2), where charging a capacitor is determined by using the equivalence $Q_g = C_{LOAD}V_{DD}$. The gate charge includes the effects of the input capacitance plus the added charge needed to swing the drain voltage of the power device as it switches between the ON and OFF states. Manufacturers provide specifications that provide the typical and maximum gate charge, in nC, to switch the device under specified conditions.

$$P_G = Q_g * V_{DD} * f_{SW} \tag{2}$$

Where

- Qg is the gate charge of the power device
- fsw is the switching frequency
- V_{DD} is the supply voltage

If R_G applied between driver and gate of power device to slow down the power device transition, the power dissipation of the driver shows as below:

$$P_{G} = \frac{1}{2} * Q_{g} * V_{DD} * f_{SW} * \left(\frac{R_{OL}}{R_{OL} + R_{G}} + \frac{R_{OH}}{R_{OH} + R_{G}}\right)$$
(3)



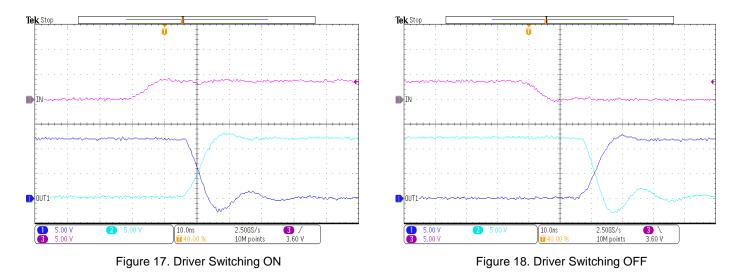
Where

- ROH is the equivalent pull up resistance of SCT52241
- RoL is the pull down resistance of SCT52241
- R_G is the gate resistance between driver output and gate of power device.



SCT52241

Application Waveforms





Layout Guideline

The SCT52241 provides the 4A output driving current and features very short rising and falling time at the power devices gate. The high di/dt causes driver output unexpected ringing when the driver output loop is not designed well. The regulator could suffer from malfunction and EMI noise problems if the power device gate has serious ringing. Below are the layout recommendations with using SCT52241 and Figure 19 is the layout example.

Put the SCT52241 as close as possible to the power device to minimize the gate driving loop including the driver output and power device gate. The power supply decoupling capacitors needs to be close to the VDD pin and GND pin to reduce the supply ripple.

Star-point grounding is recommend to minimize noise coupling from one current loop to the other. The GND of the driver connects to the other circuit nodes such as source of power MOSFET or ground of PWM controller at single point. The connected paths must be as short as possible to reduce parasitic inductance. A ground plane is to provide noise shielding and thermal dissipation as well.

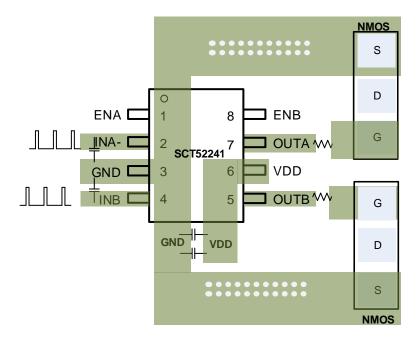


Figure 19. SCT52241 PCB Layout Example

Thermal Considerations

The maximum IC junction temperature should be restricted to 150°C under normal operating conditions. Calculate the maximum allowable dissipation, $P_{D(max)}$, and keep the actual power dissipation less than or equal to $P_{D(max)}$. The maximum-power-dissipation limit is determined using Equation (4).

$$P_{D(MAX)} = \frac{150 - T_A}{R_{\rm \theta JA}} \tag{4}$$

where

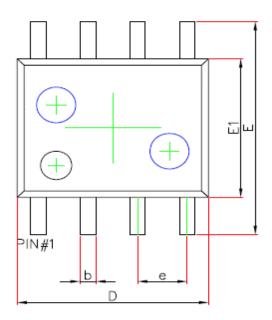
- T_A is the maximum ambient temperature for the application.
- R_{0JA} is the junction-to-ambient thermal resistance given in the Thermal Information table.



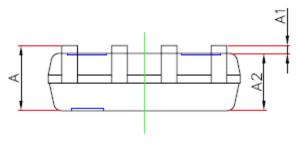
The real junction-to-ambient thermal resistance $R_{\theta JA}$ of the package greatly depends on the PCB type, layout, and environmental factor. Soldering the ground pin to a large ground plate enhance the thermal performance. Using more vias connects the ground plate on the top layer and bottom layer around the IC without solder mask also improves the thermal capability.



PACKAGE INFORMATION (SOP-8)



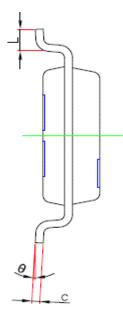
TOP VIEW



SIDE VIEW

NOTE:

- 1. Drawing proposed to be made a JEDEC package outline MO-220 variation.
- 2. Drawing not to scale.
- 3. All linear dimensions are in millimeters.
- 4. Thermal pad shall be soldered on the board.
- 5. Dimensions of exposed pad on bottom of package do not include mold flash.
- 6. Contact PCB board fabrication for minimum solder mask web tolerances between the pins.

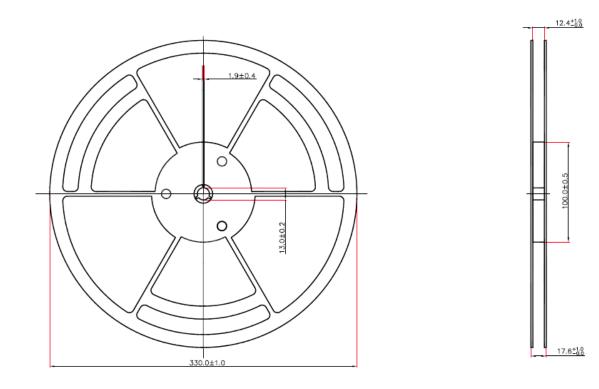


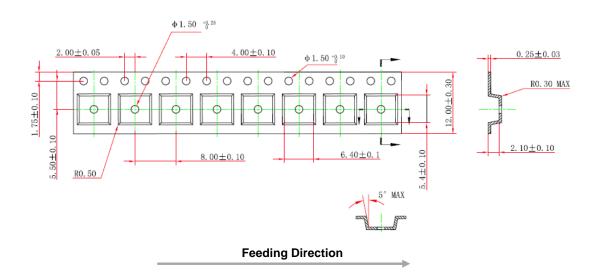
BOTTOM VIEW

SYMBOL	Un	Unit: Millimeter			
STMBUL	MIN	TYP	MAX		
А	1.35		1.75		
A1	0.1		0.25		
A2	1.35		1.55		
b	0.33		0.51		
С	0.17		0.25		
D	4.7		5.1		
E	5.8		6.2		
E1	3				
е	1.27BSC				
L	0.4		0.8		
θ	0°		8°		



TAPE AND REEL INFORMATION

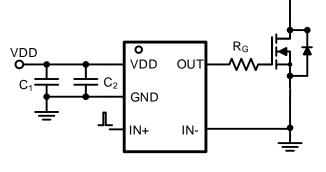


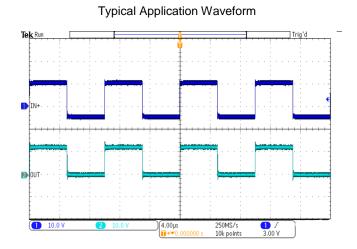




TYPICAL APPLICATION

Single Channel, Non-Inverting MOSFET Gate Drive Typical Application





RELATED PARTS

PART NUMBERS	DESCRIPTION	COMMENTS	
SCT51240	Up to 24V Supply, 4-A Single Channel High Speed Low Side Driver	 Compatible for both Inverting and Non-inverting application Supporting down to -5V input 	

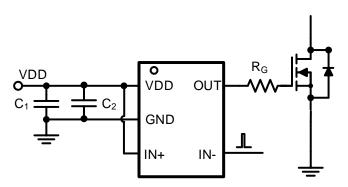


Figure 20. SCT51240 Inverting MOSFET Gate Drive Typical Application

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